



# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE OF 101 Rec'd PC17

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Application Serial No		Filed Herewith
Filing Date		Frank Melzer et al.
Assignee		
Group Art Unit		Not Yet Assigned
Examiner		Not Yet Assigned
Attorney's Docket No		LO29-016
Title: Lighting System, Particularly for Us	se in Extreme Ultraviolet	(EUV) Lithography

### INFORMATION DISCLOSURE STATEMENT

References -- See Attached Form PTO-1449

The citations listed may be material to the examination of the subject application and are therefore submitted in compliance with the duty of disclosure defined in 37 CFR §1.56. Copies of the cited art are included with the exception of U. S. patents and published U.S. applications (1276 Off. Gaz. Pat. Off., 05 August 2003). No admission is made regarding whether all the submitted references are prior art. The Examiner is requested to make these citations of official record in this application.

The materials cited are presented to assist in and expedite examination of this application. The present invention is considered to be patentable over the cited materials. Expeditious examination and allowance of this application as a patent are therefore urged in order that the public may benefit from the disclosure and commercialization of the invention.

Citation of these references is respectfully requested.

Respectfully Submitted

DATED: 10-21-04

D. Brent Kenady Reg. No. 40,045

Customer No. 021567

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Form PTO-1449

# U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.

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